

PCN# 20140304002A Qualification of HNT and JCET Chuzhou as Additional Assembly/Test Site for Select Devices Change Notification / Sample Request

Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

We request you acknowledge receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If you require samples or additional data to support your evaluation, please request within 30 days.

The changes discussed within this PCN will not take effect any earlier than **90** days from the date of this notification, unless customer agreement has been reached on an earlier implementation of the change. This notification period is per TI's standard process.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Manager (<u>PCN ww admin team@list.ti.com</u>).

Sincerely,

PCN Team SC Business Services Phone: +1(214) 480-6037 Fax: +1(214) 480-6659

PCN Num	ber:	20	140	304002	A			PCN Da	ite:	03/19/2014
Title:	Qualification of Devices	of H	INT	and JCE	T Chuzh	iou as Additiona	l Ass	sembly/Tes	st Site	e for Select
Customer	Contact:	PCN	N Ma	nager	Phone	+1(214)480-	603	7 Dept:	Qu	ality Services
Proposed	1 st Ship Date		06/	/19/2014		mated Sample			Date	Provided at
-			00/	19/201-	⁺ Avai	lability:			Sam	ple request
Change T										
	embly Site		<u>Ц</u>		bly Proc			Assembly		
Desi			<u>Ц</u>		cal Spec					pecification
Test			<u>Ц</u>			ng/Labeling	ЦЦ	Test Pro		
	er Bump Site		<u>Ц</u>		Bump M		닏님	Wafer Bu		
Wafe	er Fab Site		<u>Ц</u>		Fab Mat			Wafer Fa	ib Pro	ocess
				Part nu	<u>imber cl</u>					
					PCN	Details				
	on of Change					e been added to				
 date of this notice. The proposed first ship date applies only to the highlighted devices. Qualification of HNT and JCET Chuzhou as Additional Assembly/Test Site for Select Devices. Material differences between Assembly/Test sites as follows: Group 1 Devices: Assembly Site change only. No Assembly material differences. 										
Group 2 [Devices:									
				NS	E	HANA				
Mol	d Compound			CZ01	40	450176				
Group 3 [
Group 5 L	vevices .			NFM	IF	JCETCZ		7		
Mol	d Compound			R-1		0131020244	01	-		
	e Type			Au		Cu	<u> </u>			
Test cover test MQ.	age, insertions	, со	ondi	tions wil	ll remair	n consistent with	n cur	rent testin	g and	d verified with
	or Change:									
Continuity										
	,			The Tree			- 1- 11		/	
	ed impact on	FOI	r m ,	Fit, Fur	nction,	Quality or Reli	adii	ity (positi	ve /	negative):
None										
Changes to product identification resulting from this PCN:										
	nd 2 Devices									1
Assembl										
NSE Tha						ite Origin (22L)			SO:	
Hana Thailand Assembly Site Origin (22L) ASO: HNT					HNT					
ASSEMBLY SITE CODES: NSE =J, HANA =H										
Group 3 Devices: Assembly Site										
					۸ -	amply Cita Oria	nin (
NFME Ch						sembly Site Orig				SO: NFM
JCET Chuzhou China Assembly Site Origin (22L) ASO: GP6 ASSEMBLY SITE CODES: NEME = E ICETC7 = E										
ASSLINDL	ASSEMBLY SITE CODES: NFME =E, JCETCZ =F									

Sample product shipping label (not actual product label) TEXAS INSTRUMENTS MADE IN: Malaysia 20: MSL 2 /260C/1 YEAR SEAL DT MSL 1 /235C/UNLIM 03/29/04 OPT: ITEM: SA (L)T0:1750 (not actual product label) (1P) SN74LS07NSR (a) 2000 (D) 0336 (31T)LOT: 3959047MLA (4W) TKY (1T) 7523483S12 (P) (2P) REV: (V) 0033317 (20L) CS0: SHE (21L) CC0:USA (2L) AS0: MLA (23L) AC0: MYS								
Group 1 Product Affe	ected:	-						
TPS61040DDCR	TPS62240DDCT	TPS62260DDCT	TPS62561DDCR					
TPS61040DDCT	TPS62240DDCTG4	TPS62260DDCTG4	TPS62561DDCT					
TPS62240DDCR	TPS62260DDCR	TPS62262DDCR						
TPS62240DDCRG4	TPS62260DDCRG4	TPS62262DDCT						
Group 2 Product Affected:								
TPS62230DRYR	TPS622314DRYR	TPS62231DRYR	TPS62236DRYR					
TPS62230DRYT	TPS622314DRYT	TPS62231DRYT	TPS62236DRYT					
TPS622310DRYR	TPS622315DRYR	TPS62232DRYR	TPS62237DRYR					
TPS622310DRYT	TPS622315DRYT	TPS62232DRYT	TPS62237DRYT					
TPS622311DRYR	TPS622316DRYR	TPS62233DRYR	TPS62238DRYR					
TPS622311DRYT	TPS622316DRYT	TPS62233DRYT	TPS62238DRYT					
TPS622312DRYR	TPS622317DRYR	TPS62234DRYR	TPS62239DRYR					
TPS622312DRYT	TPS622317DRYT	TPS62234DRYT	TPS62239DRYT					
TPS622313DRYR	TPS622318DRYR	TPS62235DRYR						
TPS622313DRYT	TPS622318DRYT	TPS62235DRYT						
Group 3 Product Affected:								
CD4051BE	LM339N	LM393P	ULN2003AN					
LM324N	LM358P	NE555P						
LM324NE3	LM358PE3	SN74HC164N						
	Group 1 Ou	alification Data						
his qualification has been specifically developed for the validation of this change. The qualification data								

This qualification has been specifically developed for the validation of this change. The qualification data validates that the proposed change meets the applicable released technical specifications.

Qual Vehicle : TPS62260DDCR (MSL1-260C)							
Package Construction Details							
Assembly Site: HNT		Mold Compo		ound:	450207		
# Pins-Designator, Family: 5-DDC		C, SOT	Mount Compound:		400151		
Lead Finish, Base NiPdA		u, Cu	Bond Wire:		1.3 Mil Dia. Au		
Qualification: 🗌 Plan 🛛 Test Results							
Reliability Test		Conditions		Sample Size / Fail			
Electrical Characterization	-		15/0				
Manufacturability (Assembly)	(per mfg. Site s	pecification)		Pass			
Reference Qualification:							

Qual	Qual Vehicle 1: TPS62220DDC (MSL1-260C)						
	Package Construct	tion Details	_				
Assembly Site:	HNT	Mold Compo			ound: 450207		
# Pins-Designator, Family:	5-DDC, SOT	Mount Comp		40	0151		
Lead Finish, Base	NiPdAu, Cu	Bond	Wire:	1.0) Mil Dia.	Au	
:	Test Results						
Reliability Test Conditions Sample Size / Fail					Fail		
,			Lot#		Lot# 2	Lot# 3	
**Autoclave	121C, 2 atm (2	40 Hrs)	77/0)	77/0	77/0	
**Temperature Cycle	-65/150 (1000	cycles)	77/0)	77/0	77/0	
**Thermal Shock	-65/150 (1000	cycles)	77/0)	77/0	77/0	
X-ray	(top side only)		5/0		5/0	5/0	
Flammability	Method A - UL9	4-0	5/0		5/0	5/0	
Flammability	Method B - IEC	695-2-2	5/0		5/0	5/0	
Flammability	Method C - UL	1694	5/0		5/0	5/0	
Manufacturability (Assembly) (per mfg. Site specification) Pass Pass F			Pass				
Moisture Sensitivity (Level 1 @ 260C peak +5/-0C) 12/0)	12/0	12/0		
**- Preconditioning sequence:	Level 1-260C.						
Qua	Qual Vehicle 2: TPS71533DCK (MSL1-260C)						
	Package Construct	tion Details					
Assembly Site:	HNT	Mold Compound:			0207		
# Pins-Designator, Family:	5-DCK, SOT	Mount Compound:		40	0151		
Lead Finish, Base	NiPdAu, Cu	Bond Wire:		e: 1.25 Mil Dia. Au		i. Au	
Qualification: 🗌 Plan 🛛 Test Results							
Reliability Test Conditions Sample Size / Fail							
Lot# 1 Lot# 2 Lot# 3							
**Autoclave 121C, 2 atm (240 Hrs) 77/0 77/0 77/0							
**Temperature Cycle -65/150 (1000 cycles) 77/0 77/0 77/0				77/0			
**Thermal Shock	-65/150 (1000		77/0)	77/0	77/0	
**HAST	130C/85%RH (96 Hrs)	77/0)	77/0	77/0	
**Life test	155C (240 Hrs)		116/	0	116/0	116/0	
**High-Temp Storage Bake	170C (420 Hrs)		77/0)	77/0	77/0	
Manufacturability (Assembly)	(per mfg. Site s	specification)	Pass	5	Pass	Pass	
**- Preconditioning sequence:	Level 1-260C.						
Group 2 Qualification Data							

 Group 2 Qualification Data

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 validates that the proposed change meets the applicable released technical specifications.

Qual Vehicle : TPS62234DRYT (MSL1-260C)						
Package Construction Details						
Assembly Site: HNT			Mold Compound:		450176	
# Pins-Designator, Family: 6-DRY		, SON	Mount Compound:		400173	
Lead Finish, Base NiPdA		u, Cu	Bond Wire:		1.0 Mil Dia. Au	
Qualification: 🗌 Plan 🛛 Test Results						
Reliability Test		Conditions		Sample Size / Fail		
Electrical Characterization	-			15/0		
Manufacturability (Assembly)	(per mfg. Site s	pecification)		Pass		
Reference Qualification:						

Qual Vehicle 1: TPD4S014DRY (MSL1-260C)						
	Package Construct	tion Details				
Assembly Site: I	HNT	Mold Compound: 450176				
	6-DRY, SON	Mount Compo		400173		
	NiPdAu, Cu			1.0 Mil Dia.	Au	
	Test Results					
Reliability Test	Conditions		Sa	ample Size /	' Fail	
,			Lot#		Lot# 3	
X-ray	(top side only)		5/0	5/0	5/0	
Manufacturability (Assembly)	(per mfg. Site s	specification)	Pass	Pass	Pass	
Moisture Sensitivity	(Level 1 @ 260	C peak +5/-0C)	12/0	12/0	12/0	
**- Preconditioning sequence: L	Level 1-260C.					
Qual V	/ehicle 2: TS3A4415	9RSV (MSL1-260	C)			
Package Construction Details						
Assembly Site: HNT Mold Cor			ound:	450176		
# Pins-Designator, Family: 16-RSV, QFN Mount Compound: 400173						
Lead Finish, Base NiPdAu, Cu Bo			Wire:	0.8 Mil Dia.	Au	
Qualification: 🗌 Plan 🛛 Test Results						
Reliability Test	Conditions	Conditions		Sample Size / Fail		
			Lot#	1 Lot# 2	Lot# 3	
**Life Test	150C (300 Hrs)	150C (300 Hrs)) 116/0	116/0	
**Biased HAST	130C/85%RH (130C/85%RH (96 Hrs)		77/0	77/0	
**Autoclave	121C, 2 atm (9	121C, 2 atm (96 Hrs)		77/0	77/0	
**Temperature Cycle	-65/150 (1000	cycles)	77/0	77/0	77/0	
**High-Temp Storage Bake 150C (1000 Hrs) 77/0 77/0 77/0				77/0		
			5/0			
Flammability Method IEC 695-2-2 5/0 5/0 5/0						
			5/0	5/0		
X-ray (top side only) 5/0			5/0	5/0		
					22/0	
			Pass			
Moisture Sensitivity	(Level 1 @ 260	C peak +5/-0C)	12/0	12/0	12/0	
**- Preconditioning sequence: L	Level 1-260C.					
Group 3 Qualification Data						

Group 3 Qualification Data

This qualification has been specifically developed for the validation of this change. The qualification data validates that the proposed change meets the applicable released technical specifications.

Qual Vehicle 1: LM358P							
Package Construction Details							
Assembly Site:	JCET CHUZHOU	Mold Compound:	013102024401				
# Pins-Designator, Family:	8-N, PDIP	Mount Compound:	011204001701				
Lead Finish, Base	Matte Sn, Cu	Bond Wire:	1.0 Mil Dia. Cu				

Qualification: 🗌 Plan 🛛 Te	st Results						
Reliability Test	Conditions		Sample Size		ple Size /	. / Fail	
					Lot# 2	Lot# 3	
Electrical Characterization	-	-		5	-	-	
Autoclave	121C, 2 atm (1	92 Hrs)	77/0)	-	-	
Temperature Cycle	-65/150 (500 c	ycles)	77/0)	-	-	
Biased HAST	130C/85%RH (192 Hrs)	77/0)	77/0	77/0	
High Temp. Storage Bake	170C (600 Hrs)		77/0)	-	-	
Life Test	150C (300 hrs)		77/0)	-	-	
Salt Atmosphere	24 Hrs		22/0)	22/0	22/0	
X-ray	(top side only)		5/0		5/0	5/0	
Solderability	8 Hours Steam	Age	22/0)	22/0	22/0	
Flammability	Method A - UL9	94-0	5/0		5/0	5/0	
Flammability	Method B - IEC	695-2-2	5/0		5/0	5/0	
Flammability	Method C - UL 1694		5/0		5/0	5/0	
Manufacturability (Assembly)	(per mfg. Site s	(per mfg. Site specification)		5	Pass	Pass	
Qual Vehicle 2: SN74HC164N							
Package Construction Details							
Assembly Site: JCE	r chuzhou	Mold Comp	ound:	01	.3102024	401	
# Pins-Designator, Family: 14-N	N, PDIP	Mount Comp	ound: 011204001701		701		
Lead Finish, Base Matt	e Sn, Cu	Bond	Wire: 1.0 Mil Dia. Cu		Cu		
Qualification: 🗌 Plan 🛛 Test Results							
Reliability Test	Conditions	Sam			nple Size / Fail		
				1	Lot# 2	Lot# 3	
Electrical Characterization	-	-		5	-	-	
Autoclave	121C, 2 atm (2	121C, 2 atm (240 Hrs))	-	-	
Life Test	150C (300 hrs)		77/0)	-	-	
Temperature Cycle	-65/150 (1000	cycles)	77/0)	-	-	
Biased HAST	130C/85%RH (130C/85%RH (192 Hrs))	-	-	
High Temp. Storage Bake	170C (600 Hrs)		77/0)	-	-	
X-ray	(top side only)		5/0		5/0	5/0	
Solderability	Pb Free/Solder		22/0)	22/0	22/0	
Manufacturability (Assembly)	(per mfg. Site s	specification)	Pass	5	Pass	Pass	

	Qual Vehicle 3: CD4051BE						
Package Construction Details							
Assembly Site:	CHUZHOU	Mold Comp	ound: 013102024401		401		
# Pins-Designator, Family:	16-N,	PDIP	Mount Comp	ound:	011204001	701	
Lead Finish, Base	Matte	Sn, Cu	Bond	Wire:	1.0 Mil Dia.	Cu	
	🛛 Test	Results					
Reliability Test		Conditions		S	ample Size /	' Fail	
				Lot#	1 Lot# 2	Lot# 3	
Electrical Characterization		-		Pass		-	
Autoclave		121C, 2 atm (2	40 Hrs)	77/0		77/0	
Temperature Cycle		-65/150 (1000		77/0		77/0	
Biased HAST	130C/85%RH (192 Hrs)			77/0	77/0		
High Temp. Storage Bake	170C (600 Hrs)	77/0		77/0			
X-ray	(top side only)	5/0	5/0	5/0			
Solderability	8 Hours Steam Age			22/0	22/0		
Flammability	Method A - UL94-0			5/0	5/0		
Flammability	Method B - IEC	5/0 5/0	5/0	5/0			
Flammability	Method C - UL 1694			5/0	5/0		
Manufacturability (Assembly)		(per mfg. Site specification) Pa			Pass	Pass	
	Qual Vehicle 4: ULN2003AN						
		kage Construct		Г			
Assembly Site: JCET C		CHUZHOU	Mold Compound:				
# Pins-Designator, Family: 16-N, PDI		PDIP	Mount Compound: 011204001701		701		
Lead Finish, Base	Sn, Cu	Bond	Wire:	1.0 Mil Dia.	.0 Mil Dia. Cu		
Qualification: 🗌 Plan 🛛 Test Results							
Reliability Test		Conditions			ample Size /		
				1 Lot# 2	Lot# 3		
Biased HAST		130C/85%RH (1	77/0		77/0	
Manufacturability (Assembly)		(per mfg. Site s	specification)	Pass	Pass	Pass	

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com